## Measuring Effective Temperatures of Qubits Using Correlations

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Initialization of a qubit in a pure state is a prerequisite for quantum computer operation. A plethora of ways to achieve this has been proposed in the last decade, from active reset protocols to advances in materials and shielding. An instrumental tool to evaluate those methods and develop new ones is the ability to measure the population of excited states with high precision and in a short period of time. In this Letter, we propose a new technique of finding the excited state population of a qubit using correlations between two sequential measurements. We experimentally implement the proposed technique using a circuit QED platform and compare its performance with previously developed ones. Unlike other techniques, our method does not require high-fidelity readout and does not involve the excited levels of the system outside of the qubit subspace. We experimentally demonstrated measurement of the spurious qubit population with accuracy of up to 0.01%. This accuracy enabled us to perform "temperature spectroscopy" of the qubit, which helps to shed light on decoherence sources.

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Residual population of the excited state of superconducting qubits has been routinely measured to be many orders of magnitude higher than the one predicted from the Maxwell-Boltzmann (MB) distribution with a temperature of a dilution refrigerator. For the temperature of  $\lesssim 20 \text{ mK}$ and for qubit frequencies ~5 GHz one might expect the population of the excited state  $P_e < 10^{-5}$ , while the measured values are much larger and might even exceed 1% [1–7]. This unexpected increase of the effective temperature of a qubit is one of the factors limiting the fidelity of operations in superconducting quantum processors and may be also an indication of extra decoherence channels for the qubit. Potential reasons for this spurious population may include hot out-of-equilibrium quasiparticles [8–11] generated by stray radiation [1,12] or cosmic rays [10,11] and microwave noise [13, 14] from the higher stages of a dilution refrigerator.

In order to quantify the quality of the state initialization and, more importantly, to identify and eliminate the sources of spurious excitation, one needs to resolve the changes in the excited state population of a qubit within fractions of a percent. Using dispersive measurement with quantum limited amplification provides high signal-to-noise ratio (SNR) sufficient for a single-shot readout of the qubit state and enables direct counting of the excited state population by repeated measurement. Due to technical restrictions it is not always possible to use quantum limited amplifiers and, sometimes, it is not possible to reach the required measurement contrast even in the presence of quantum-limited amplification. An alternative method involves the third level of a system employed as a qubit: the amplitude of Rabi oscillations between the first and second excited states can be used as a measure of excited state population [4,15]. This method cannot be applied if the higher levels are not accessible due to large discrepancy of transition frequencies or selection rules [16].

In this Letter, we introduce a method allowing to measure the excited state ( $|e\rangle$  state) population (or effective temperature  $T_{\rm eff}$ ) of a qubit using correlations between two sequential measurements. Utilizing the quantum nondemolition (QND), i.e., projective, nature of the measurement, we lift the requirements for high-fidelity single-shot readout or for manipulations involving higher levels of the system employed as a qubit to measure its effective temperature. The accuracy limit of our method is not limited by SNR and is only sensitive to qubit decoherence and gate errors in the second order. Because of that we achieve the highest reported precision of the excited state population measurement with accuracy of 0.01% and study its dependence on the qubit transition frequency. Although our experimental demonstration is carried out on the platform of circuit quantum electrodynamics (QED) and transmon qubits, the method is generic and is applicable to any system where the QND measurement can be realized.

Our experimental system consists of a tunable-frequency superconducting qubit, called a transmon, coupled to a 3D microwave cavity. The cavity is employed to both carry the microwave pulses to manipulate the qubit and to readout its state. The transmon has a weakly anharmonic multilevel structure, and its two lowest energy eigenstates are used as the logical states  $|g\rangle$  and  $|e\rangle$  of a qubit. We are also using the next energy eigenstate  $|f\rangle$  to realize the qutrit protocol mentioned above [4,15] for comparison. The system is tuned to the dispersive regime, where the qubit  $|g\rangle$ - $|e\rangle$  transition frequency is far from the cavity transition frequency, so the standard dispersive readout method can be employed [17]. For low readout powers the dispersive readout has highly quantum nondemolition nature with negligible contribution to qubit excitation due to readout. To achieve a high SNR to be able to readout a transmon state in a single-shot regime we use a Josephson parametric amplifier (JPA) similar to one described in Ref. [18].

We first present the idea of our method using a notion of an abstract ideal quantum two-level system with an instant and noiseless quantum nondemolition measurement. We can define the measurement apparatus to yield a real value  $V_g$  for the qubit in the ground state and  $V_e$  for the qubit in the excited state. By repeating the same experiment many times the average value of the measurement response is expressed as

$$\langle V \rangle = g^{(0)} = P_g V_g + P_e V_e \equiv \tilde{V}_g, \tag{1}$$

where  $P_e$  is spurious  $|e\rangle$ -state population,  $P_g = 1 - P_e$  is the ground state population, and  $g^{(0)}$  is zeroth order correlation function. Knowledge of  $\langle V \rangle$  can be in principle sufficient to determine the excited state population  $P_e$  if the responses  $V_{g/e}$  are known. Unfortunately, these responses are generally not known *a priori* and to determine  $P_e$  one needs to make additional measurements such as some measurements involving the second excited level [4,15]. Instead of using the higher excited levels we propose to measure the first order correlation function  $q^{(1)}(\tau) = \langle V(0)V(\tau) \rangle$ .

Assuming that our measurement is QND the second subsequent measurement will return a fully correlated result

$$g^{(1)}(0) = P_g V_g^2 + P_e V_e^2.$$
 (2)

This value can be compared to

$$g^{(1)}(\infty) = (g^{(0)})^2 \le g^{(1)}(0),$$
 (3)

where we assumed that the measurements will be fully uncorrelated if separated by long times. It is also straightforward to see that the equality  $g^{(1)}(0) = g^{(1)}(\infty)$  is realized only if the qubit is its ground state  $P_g = 1$  (or  $P_e = 1$ ).

Measurement of a typical decay of the correlation function is shown in Fig. 1. It follows an exponential curve with the relaxation time  $T_1$  of the qubit. Observation of this decay is the manifestation of the spurious  $|e\rangle$ -state qubit population. However, to determine  $P_e$  quantitatively we need to add a calibration measurement. For example, we can apply a  $\pi$ pulse to swap the ground and excited state populations before taking a measurement (see Fig. 2) returning

$$g_{\pi}^{(0)} = P_e V_q + P_q V_e \equiv \tilde{V}_e. \tag{4}$$

Using simple calculations and an assumption of  $P_e$  being small (see the Supplemental Material [19]) one can obtain



FIG. 1. Decay of the normalized correlator between two sequential measurements separated by  $\tau$ . The solid lines represent exponential  $T_1$  decay. Amplitude of the correlator at zero (or lowest attainable) delay allows one to reconstruct the  $|e\rangle$ -state population and hence the effective temperature of the qubit.

$$P_e \simeq \frac{g^{(1)}(0) - (g^{(0)})^2}{\left(g^{(0)} + g^{(0)}_{\pi} - 2\sqrt{g^{(1)}(0)}\right)^2}.$$
 (5)

In circuit QED platform, we use the integrated heterodyne voltage transmitted through a resonator as an output of measurement apparatus. Heterodyne voltage is complex valued, so we can use both quadratures as real-valued responses of the measurement apparatus. In practice, it is easier to work with a normalized real voltage  $\bar{V} = \text{Re}[(V - \tilde{V}_g)/(\tilde{V}_e - \tilde{V}_g)]$ , which is dimensionless and is defined to have the maximal distance between the ground and excited state responses. The zeroth order correlation functions of  $\bar{V}$  are of a particularly simple form:  $\bar{g}^{(0)} \equiv P_g \bar{V}_g + P_e \bar{V}_e = 0$  and  $\bar{g}_{\pi}^{(0)} \equiv P_e \bar{V}_g + P_g \bar{V}_e = 1$ . That allows us to write an exact simple expression for the spurious  $|e\rangle$ -state population (see the Supplemental Material [19]) as

$$P_e = \frac{1}{2} - \frac{1}{2\sqrt{1 + 4\bar{g}^{(1)}(0)}} \simeq \bar{g}^{(1)}(0), \tag{6}$$

where  $\bar{g}^{(1)}(0) \equiv \langle \bar{V}(0)\bar{V}(\tau)\rangle|_{\tau=0}$  and the approximation holds when  $P_e \ll 1$ .

In reality, measurement of the correlation function returns  $\bar{g}^{(1)}(\tau) = \langle \bar{V}(0)\bar{V}(\tau) \rangle + \langle \eta(0)\eta(\tau) \rangle$ , where  $\eta$  includes contributions of all noise sources such as noise of the amplification chain and the quantum noise. For a typical experimental setup the measurement noise is "fast" and  $\langle \eta(0)\eta(\tau) \rangle$  can be expressed as  $\langle \eta \rangle^2 = 0$  for all relevant timescales. The noise contribution can be suppressed by acquiring sufficient statistics for all  $\tau > 0$ . The noise contribution at  $\tau = 0$  can be, in principle, subtracted by performing additional calibration measurement of  $\langle \eta^2 \rangle$ . In our experiments, we simply approximated  $\bar{g}^{(1)}(0)$  by a correlator

Run I	$g^{(0)} \& g^{(1)}( au)$		Read out	Delay $( au)$	Read out	
Run II	$g_{\pi}^{(0)}$	π	Read out			

FIG. 2. The experimental protocol. "Run I" represents measurement of the correlation function  $g^{(1)}(\tau)$  and  $g^{(0)}$ . "Run II" is an additional calibration measurement required for correct scaling of  $P_e$ . The variable delay was used to measure the decay of  $g^{(1)}(\tau)$ . To determine  $P_e$  only one measurement with  $\tau = 0$  is necessary.

of the results of two sequential measurement in time (see Fig. 2). Systematic study of the standard deviation of  $\bar{g}^{(1)}(0)$  shows the expected scaling with a number of averages N up to  $N = 2^{16}$  confirming the absence of any measurable "slow" noise contribution in our measurement setup (see below).

Results.—We have performed a study of residual excited state population of a Transmon qubit vs the temperature of the mixing chamber (MC) plate of a dilution refrigerator shown in Fig. 3. For each temperature point after stabilizing the MC sensor temperature we have waited ample time (> 1 hour) for the qubit and its environment to thermalize and performed measurement of the qubit  $|e\rangle$ -state population using four different methods for each MC temperature point. First, we used our method in the presence of a quantum-limited amplifier (JPA), which gives us a fairly high SNR of ~6 and allows determining the residual  $|e\rangle$ -state population with the precision of .01% in 15 minutes, which is the highest precision reported [7,15]. Interestingly, the standard deviation of our method was smaller than the direct counting of excitations using the same data.

In the second measurement we used our method without the JPA. It resulted in a SNR of 0.9 which is not sufficient for a single-shot measurement. The results were in agreement with the precise measurements, thus demonstrating the ability of our method to work in the conditions of low SNR [Fig. 3(a)]. We have also used conventional methods to determine the  $|e\rangle$ -state population using the second excited state of the Transmon and the direct count of single shots making use of JPA [18]. All methods' results are in agreement within the error bars but show different statistical and systematic errors [see Fig. 3(b) and below for more comments).

The residual  $|e\rangle$ -state population of our qubit as function of the temperature of MC plate coincides within the error bars (< 0.01% uncertainty) with the M-B curve shifted by a "zero-temperature excitation" offset (the curve is indicated on the plot with a solid black line). Note that both the offset value and the M-B distribution have no free parameters: the offset is given by the measurement at the lowest attainable temperature and the qubit transition energy was obtained independently using spectroscopy and Ramsey-type measurement. Our results are somewhat different from the conclusion of Ref. [15] where spurious excitation followed



FIG. 3. (a) Measured  $|e\rangle$ -state population as a function of the mixing chamber sensor temperature. Red points are correlator measurements with a JPA. Data for each point corresponds to  $2^{20}$  repetitions. The blue points are measured with JPA turned off. The black solid line corresponds to the M-B distribution offset by 0.33% as indicated by the dashed green line. The error-bars cover two standard deviations in measurement (95% confidence). (b) Deviation of the data from the M-B distribution for different methods. Correlator measurements with JPA on (red) and single-shot counting method (brown) have comparable  $1\sigma$  uncertainties of 0.01% and 0.03%, respectively. Correlator method with JPA off (blue) and the qutrit protocol (purple) have also comparable, but much higher uncertainties (see text for more details).

the M-B distribution without an offset, but saturated at the temperature of 35 mK.

The presence of this offset may be explained by a model of a qubit being coupled to two separate thermal baths. One of the baths is strongly coupled to the qubit and thermalized with the MC plate of a dilution refrigerator, while the second bath is weakly coupled but has a much higher temperature independent of the MC temperature. We determined the rate of excitation and relaxation events from this second, nonequilibrium source, to not exceed 670 Hz, corresponding to a time constant of 1.5 ms which is consistent with "hot" out-of-equilibrium quasiparticles as a possible origin for the qubit excitation [9,23].

To acquire more information on the origin of the qubit excitation we used our method to perform "temperature spectroscopy" by measuring the  $|e\rangle$ -state population as a function of the qubit frequency. Figure 4 shows that the  $|e\rangle$ -state population peaks around 6 GHz and can change abruptly with even small changes in the qubit frequency.



FIG. 4. Excited state population vs qubit frequency representing a "noise spectrum" as seen by the qubit. The green arrow indicates the qubit frequency used for the rest of the experiments.

This behaviour is inconsistent with the excitation by quasiparticles whose matrix element is a smooth function of qubit frequency [24]. Instead, this behavior is characteristic to coupling to two-level systems, which are believed to be the dominant source of the qubit relaxation and exhibit a strong non-monotonic dependence of relaxation times of superconducting qubits on their frequencies [20].

Precision and errors.—Direct counting of  $|e\rangle$ -state population with single-shot readouts provides the most direct method of  $|e\rangle$ -state population measurement without use of any control pulses and was very instructive for a reliable verification of our method. Unfortunately, direct counting is only possible for a readout with sufficiently large SNR. With lower SNR the absolute error due to state misinterpretation rises exponentially thus limiting the practicality of this method for temperature measurement, especially for very small spurious populations.

The largest systematic error source of our method comes from the finite time of the measurement, which leads to a partial decay of the correlations following the standard  $T_1$ decay curve (see Fig. 1). While this error can be considerable, a separate measurement of  $T_1$  can be used to correct for this error. Most importantly, this error is relative, as it only decreases the measured  $P_e$  by a factor of  $e^{-T_{\text{meas}}/T_1}$ , where  $T_{\text{meas}}$  is the measurement time. Therefore, this error does not set a lower limit on the measurable spurious population unlike the error of the finite SNR for the direct counting.

A similar effect is due to  $\pi$ -pulse errors. As this error only affects  $\tilde{V}_e$  which is measured independently from  $g^{(1)}$ , it only contributes as a relative error and does not affect statistical distribution for  $P_e$ . Moreover, if an infidelity of the  $\pi$  pulse is small this error contributes to  $P_e$  only in the second order.

Similarly to the direct counting method, measurement of  $g^{(1)}$  does not involve any control pulses and is generally performed when the qubit is in equilibrium with environment. Therefore, the only possible systematic absolute error



FIG. 5. Relative precision of  $P_e$  measurements and their linear fits. The precision scales as expected for uncorrelated noise (indicated by the black dashed line). Inset: Population (solid line) and standard deviation (fill) for a measurement power of -30 dBm.

of our method arises from the excitation of the qubit due to dispersive readout which can be virtually arbitrarily suppressed by larger qubit detunings and/or lower readout powers.

The only statistical (not systematic) error of our method is due to measurement noise which, in turn, can be reduced by increase in averaging time. Figure 5 shows a standard deviation of measured  $|e\rangle$ -state population as a function of number of measurements and different readout powers. The error scales as  $N^{-1/2}$ , where N is the number of iterations, over the complete range deviating from this expected dependence only for the largest power of -30 dBm, most probably, due to loss of quantum nondemolition behavior of the readout.

It is interesting to note that the qutrit method demonstrated the worst accuracy which may be attributed to extra decoherence due to  $|f\rangle$  level and to the direct excitation of  $|e\rangle$  state when applying *e-f* drive. While certain optimal control techniques, such as DRAG pulses [21] for *e-f* transition, could be employed to mitigate this problem, impossibility to entirely isolate spurious  $|e\rangle$ -state excitation by the method itself poses an extra limitation on its absolute precision.

*Discussions.*—In summary, we have proposed and experimentally realized a method of measuring the effective temperature of qubits using correlations between consecutive measurements. Our method does not require usage of higher excited levels, is less susceptible to errors in control pulses and allows for virtually unlimited suppression of absolute errors even without high SNR required for the high-fidelity single-shot measurement. Our method can be used on any platform. We experimentally show it to have the highest reported precision for superconducting circuits. The accuracy of our method enables "temperature spectroscopy" giving spurious population of  $|e\rangle$  state of the qubit as function of qubit transition frequency, which can shed light on the sources of decoherence.

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